

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/682,164	<b>Applicant(s)/Patent under Reexamination</b> WILSON ET AL.
	<b>Examiner</b> Tanh Q. Nguyen	<b>Art Unit</b> 2182

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner